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Branching Transport Model of Alkali-Halide Scintillators

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We measure the time dependence of the scintillator light-emission pulses in NaI(TI) crystals at different temperatures, after activation by gamma rays. We confirm that there are two main nonexponential components to the time decay and find that their amplitude ratio shows Arrhenius temperature dependence. We explain these nonexponential components as arising from two competing mechanisms of carrier transport to the Tl activation levels. The total light output of the NaI(Tl) detectors shows a linear temperature dependence explained by our model.

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I. INTRODUCTION

Doped alkali-halide scintillation crystals, developed 50 years ago, continue to be the workhorses of outdoor gamma spectroscopy because of their size, cost, and performance. Recently, there has been a growing interest in NaI(Tl) detectors for use in Homeland Security applications [\[1,](#page-5-0) [2\]](#page-5-1). However, a well-known, problematic feature of NaI(Tl) detectors is the temperature-dependence of their light yield. The core of this problem stems from the temperature dependence of the shape and amplitude of the light pulses emitted from the scintillator for a given energy of the incident ionizing particle. Although multiple exponential components describing the shape of the light pulse in time have been reported [\[3\]](#page-5-2), the common understanding for a NaI(Tl) light pulse assumes a single dominant exponential component with a temperaturedependent decay-time constant [\[4,](#page-5-3) [5,](#page-5-4) [6,](#page-5-5) [7,](#page-5-6) [8\]](#page-5-7), based on the effective three-level activator model described in [\[9\]](#page-5-8). This is inconsistent with the well known fact that below 60^0 C, the current pulses cannot be fitted well with a single exponent, even at a fixed temperature. Until now, it has been also generally accepted that the temperature behavior of the total light output of NaI(Tl) is nonlinear and has a broad maximum below room temperature.[\[3,](#page-5-2) [4,](#page-5-3) [5,](#page-5-4) [6\]](#page-5-5).

Recent experimental results obtained by using a novel method and device demonstrated that this experimentally observed nonlinear temperature behavior arises because of a convolution between the temperaturedependent shape of the light pulse and the pulse response of the shaping circuitry [\[10\]](#page-5-9). It was shown experimentally that when a gated integrator is used, the whole light output shows only linear temperature dependence over a wide temperature range $(-30^0C \text{ to } +60^0C)$

[\[10,](#page-5-9) [11,](#page-5-10) [12,](#page-5-11) [13\]](#page-5-12). In the same work, two main components of the shape of the light pulses, with a temperature redistribution between their amplitudes, were found. Importantly, it was shown in [\[11,](#page-5-10) [12,](#page-5-11) [13\]](#page-5-12) that the slow component is negligible above room temperature, but it produces up to 40 percent of the total light at -20^0 C and lasts several microseconds. It was also shown that at high temperatures, only one almost exponential decay component exists, consistent with [\[6\]](#page-5-5).

We measured the time dependence of NaI(Tl) current pulses at different temperatures. We show that rather than one or more exponential decay components, there are two dominant nonexponential light components, corresponding to two competing mechanisms of carrier transport to the Tl activation levels. We model the transport and reproduce the experimental data with nonlinear rate equations. The data may also be fitted with two exponential decay components using fixed fast and slow time constants and an Arrhenius temperaturedependent redistribution between the amplitudes, but the accuracy is approximately 5 percent.

II. EXPERIMENTAL RESULTS

We placed a standard 2-in x 2-in. Bicron NaI(Tl) detector in an environmental chamber. The chamber temperature changed at a rate of $2^{0}C/hr$, and each set of measurements at a given temperature was taken after an 8-hr hold time to allow good thermal equilibration. We digitized the photomultiplier tube (PMT) current pulses with a 14-bit digital scope, manufactured by Gage Applied Sciences Inc., connected via a 50 Ω resistor directly to the anode of the PMT for each temperature. The temperature coefficient of the PMT was almost constant

over the investigated temperature interval [\[14\]](#page-5-13) and did not change the shape of the light pulse. The area of the pulses was selected to correspond to an excitation around 662 keV. We normalized all pulses to the unit area to study the effect on pulse shape alone. In Fig. 1, we show the time dependence of the emitted light output on a log scale, where the two components are resolved and the temperature-dependent redistribution between the amplitudes of the slow and fast components is readily seen. Note that the emission spectrum of this doped inorganic scintillator shows that the emitted light is at a single wavelength, characteristic of a transition between a single excited state of the activator and its ground state. Thus the two components of the light pulse do not represent decays from different energy levels, but rather, they represent two different pathways for the secondary electrons and holes to the activator levels. We

FIG. 1: Current pulses measured at $-200C, -100C, 00C, 100C, 200C, 300C, 500C.$ Each one normalized to its maximum value so the second component may be clearly resolved at lower temperatures.

normalized the area of the current pulses to remove the temperature-dependence arising from a competition between the scintillation transitions and the nonradiative phonon-assisted transitions. This competition take place at the excited Tl level, where the electrons and holes recombine [\[3\]](#page-5-2). The nonradiative, phonon-assisted transitions decrease the total amount of the collected light, but they play this role after the secondary carriers, electrons and holes, are recombined at the $(Tl^+)^*$ level. The nonradiative, phonon-assisted transitions do not significantly change the time shape of the current pulse. This can readily be understood at very higher temperatures where only one exponential component of the current pulses exists [\[6\]](#page-5-5) and the time shape of the pulse is almost temperature independent. On the other hand the nonradiative, phonon-assisted transitions are responsible for

the strong temperature dependence of the peak position, and this dependence can be observed at arbitrarily higher temperatures. At such high temperatures, the shape of the current pulse does not change with temperature, but the area of the pulse and the corresponding peak position for a given energy of the incident particle becomes less and less with increasing temperature..

In our measurements of the light pulses from NaI(Tl), we found an Arrhenius dependence of the ratio between the amplitudes of the two dominant components with which we fit the data. We found a similar dependence in CsI(Tl) using the numerical data published in [\[15\]](#page-5-14), as shown in Fig. [2.](#page-1-0) We found that

$$
\frac{Q_1}{Q_2} \propto e^{\left(-\frac{\Delta E}{kT}\right)},\tag{1}
$$

where $Q_1(T)$ and $Q_2(T)$ are the amplitudes of the fast and the slow components, $Q_1(T) + Q_2(T) = constant$, and ΔE is a phenomenological activation energy between the STE level and the excited Tl level.

FIG. 2: Activation dependence of the total amplitude of the current pulses for NaI(Tl) (squares) and CsI (Tl) (triangles), on a logarithmic scale. Numerical values for the amplitudes Q_1 and Q_2 of CsI(Tl) by courtesy of [\[15\]](#page-5-14).

III. THEORETICAL MODEL

Because we were sure that the observed components of the light pulses did not correspond to impurities or different energy levels, we sought to determine the primary transport mechanisms for secondary electrons and holes.

In alkali-halide crystals, the electron-hole interaction is very strong [\[16\]](#page-5-15). This leads to the formation of excitons and, because of the highly polarizable nature of the crystals, to a fast creation of self-trapped excitons

(STEs) at the very beginning of the process. This is why the earliest theoretical models of the transport in NaI(Tl) included only the motion of the excitons [\[17\]](#page-5-16). There is considerable evidence of long-lived STEs in alkali-halide crystals at low temperatures [\[18\]](#page-5-17). In NaI(Tl), a redistribution between the emitted light from the STE levels and the emitted light from the Tl activation centers above $T= 140$ K has been observed. This means that after the decay of an STE, the created electron and hole usually reach the activator centers [\[19\]](#page-5-18). The suggested transport mechanism is by phonon-assisted exciton hopping from the STE level to the Tl level. In NaI(Tl), this type of transport was observed with a temperature-dependent rate of $10^{12} - 10^8$ [s⁻¹] [\[19\]](#page-5-18).

On the other hand, a previously performed experiment on CsI(Tl) showed that the predicted dependence of the shape of the light pulse on the activator concentration, for different energies of an incident particle, is not observable [\[17,](#page-5-16) [20\]](#page-5-19). This disagreement with the existing theory led to the incorporation of a second kind of motion in the crystal: namely, the binary diffusion of electrons and holes [\[21\]](#page-5-20). The binary diffusion in these materials leads to the fast creation of localized electrons and holes in the vicinity of the activator centers and, after that, to complex mechanisms of recombination. Optical measurements [\[22,](#page-5-21) [23\]](#page-5-22) proved that the lifetime of holes trapped at Tl^{++} is surprisingly short: approximately 0.350 μ sec in NaI(Tl). Therefore, we considered another possible mechanism of STE decay, leading to the creation of separated electrons and holes and to the diffusion-transport mechanism. The mechanism we considered is the previously discovered multiphonon-assisted dissociation of the STE [\[24\]](#page-5-23). The corresponding rate is again temperature dependent, and its value is in the same range as the rate of the hopping transport.

The simple relationship shown in Eq.[\(1\)](#page-1-1) suggests that there are two transport mechanisms in competition for reaching the activated site. We propose that one is a phonon-assisted hopping transport of the STE to the Tl level, and the other is a multiphonon-assisted dissociation of the STE followed by single-carrier transport of the electron and hole to the Tl level, as shown in Fig [3.](#page-2-0) In the first channel, the STE reaches the activator levels (Tl^+) via phonon-assisted hopping, making $(Tl^+)^*$ excited levels that creates the fast component of the light output. The decay time of this component would be mainly the lifetime of the $(Tl^+)^*$ excited levels. We can infer that the combination of the lifetime of the STE level and the STE transport to the activation center is relatively fast. Note that the decay rate is determined also by the nonradiative, phonon-assisted transition between $(Tl^+)^*$ and the ground state (Tl^+) .

We associate the second (slower) component with binary transport [\[22\]](#page-5-21).The mechanism is by STEs that thermally dissociate into electrons and holes. The electrons are rapidly captured at (Tl^+) levels, making (Tl^0) levels, and the holes are quickly captured at (Tl^+) levels, making (Tl^{++}) levels. The holes may reach the (Tl^0) levels via diffusion and recombine with the electrons, thus creating $(Tl^+)^*$ excited levels that decay optically, as before. The lifetime of this process is slower than the hopping transport because it is a combination of the relatively long lifetime of the trapped hole, the diffusion time, and the lifetime of the $(Tl^+)^*$ excited level. The two processes are schematically depicted in Fig. [3.](#page-2-0)

FIG. 3: Diagram representing the two main competing processes in alkali-halide crystals. Intermediate processes creating $T l^{++}$ and $T l^0$ are omitted. The quenching levels in $T l^+$ are not shown because the nonradiative transitions change only the integrated light output. They are responsible for the linear temperature dependence of the total light output, but they do not change the temporal shape of the light emission.

Generally speaking, it is clear that both parts of the response are not simply exponential, being a convolution of the lifetimes of the trapped hole, diffusive transport, and the $(Tl^+)^*$ level in the slow component, and of the lifetime of the STE level, hopping transport, and lifetime of the $(Tl^+)^*$ level in the fast component.

We now compare this physical picture with the traditional one that is currently used [\[3,](#page-5-2) [4,](#page-5-3) [6\]](#page-5-5). Making an approximation, the established model is based on a single temperature-dependent decay-time constant [\[6\]](#page-5-5). This model actually describes the lifetime of the activator level [\[3\]](#page-5-2). It is supported from a simple consideration of the activator's center consisting of three energy levels: the ground level G, the scintillation level S, and the quenching level Q [\[9\]](#page-5-8). The calculations of the quantum efficiency q in this three levels-model lead to

$$
q = \frac{k_S \exp\left(-\frac{W_S}{kT}\right)}{k_S \exp\left(-\frac{W_S}{kT}\right) + k_Q \exp\left(-\frac{W_S + W_Q}{kT}\right)},
$$

\n
$$
q = \frac{1}{1 + \frac{k_Q}{k_S} \exp\left(-\frac{W_Q}{kT}\right)}.
$$
\n(2)

Three levels model takes into account that at temperature T, the relative populations of the levels are as follows: level S ~ exp ($-\frac{W_S}{kT}$); level Q ~ exp ($-\frac{W_S+W_Q}{kT}$). Here k_S is the probability of radiative transition from radiative level S to the ground level G, and k_Q is the probability for nonradiative transition from the quenching level Q to the ground level (so called internal quenching). W_S is the energy difference between scintillation level S and ground level G, and W_Q is the energy difference between quenching level Q and scintillation level S. The quantum efficiency calculated in this way is a monotonically increasing function with decreasing temperature, and one would expect a monotonic temperature dependence of the total light output.

However, experimentally, the temperature dependence of the light output from the NaI(Tl) scintillator was found to be strongly nonlinear [\[3,](#page-5-2) [4\]](#page-5-3), possessing a broad maximum below room temperature, in disagreement with the monotonic behavior of the quantum efficiency of the model. An additional function $f(T)$ (so called external quenching) that represents the probability of the occupation of the activator's centers or, in other words, describes the temperature dependence of total charge $Q_{total} = Q_{total}(T)$, was introduced to multiply the quantum efficiency in order to explain this nonlinear behavior [\[3,](#page-5-2) [4\]](#page-5-3). This function has been introduced to describe the nonlinear shape of the temperature dependence of the total light output. But as we pointed out, the nonlinear temperature dependence does not exist if one collects the total light using a gated integrator [\[10\]](#page-5-9). The nonlinear behavior of the peak position with temperature is different for different shapers [\[10\]](#page-5-9), because the long component produces a different fraction of the whole light at different temperatures [\[10,](#page-5-9) [11,](#page-5-10) [12,](#page-5-11) [13\]](#page-5-12). Using different shapers, we do not gather the whole light, but we cut off part of the signal produced by the long component, and therefore, we cut off part of the light that was produced via the slower pathway to the Tl level. This cutting is temperature dependent because the amount of the light that we cut belongs to the long component, and the amount of the light belonging to the long component is temperature dependent [\[10,](#page-5-9) [11,](#page-5-10) [12,](#page-5-11) [13\]](#page-5-12). The existing models for the temperature behavior of the NaI(Tl) do not take into account the complex shape of the individual light pulse, connected with the redistribution between the slow and fast component, or the simple linear temperature dependence of total light output that was recently measured [\[10\]](#page-5-9).

In our model, the total charge created from the incident ionizing particle has two main components. As we discussed above, we found experimentally that their amplitude ratio shows an Arrhenius temperature dependence, whereas their sum is a constant. This means that

$$
Q_{hopping}(T) = \frac{Q_{total} A \exp \frac{\Delta E}{kT}}{1 + A \exp \frac{\Delta E}{kT}},
$$

$$
Q_{dissociation}(T) = \frac{Q_{total}}{1 + A \exp \frac{\Delta E}{kT}}.
$$

Here, $Q_{hopping}(T)$ and $Q_{dissociation}(T)$ correspond to charges that use two different pathways for reaching the activator levels, and A is the ratio between the probability for STE decay via multiphonon dissociation and the probability for STE decay via hopping at very high temperature. Both components of the total charge are strongly temperature dependent, but their sum does not depend on temperature. That is why in our model we have $f(T) = 1$. As a consequence, we have temperature dependence of the total light output, as in the pure threelevel activator model. The quantum efficiency calculated in this model, pointed out in Eq. (2) , is a monotonically increasing function with decreasing temperature. This means that in a narrow temperature interval (kT in the range 0.03 to 0.02 eV), it can be approximated with a linear temperature dependence. Therefore in such a narrow temperature interval (T in the range -30⁰C to +60⁰C), the total collected charge Q_{total} depends almost linearly on temperature, and because of that, we will observe an almost linear temperature dependence of the total light output $L(T)$:

$$
L(T) \simeq -CT + 1,
$$

where C is a constant, and we measure in percent $L(T)$ as it was shown in $[10, 11, 12, 13]$ $[10, 11, 12, 13]$ $[10, 11, 12, 13]$ $[10, 11, 12, 13]$. At the same time, we have a strong temperature dependence and redistribution between the two main components of the light pulse, which explains the variety of the nonlinear temperature dependences of the light output when different shapers are used [\[10\]](#page-5-9).

To check the model, we simulated the processes considered above using rate equations that describe the populations of the STEs, separated electrons and holes, populations of the (Tl^{++}) , (Tl^0) levels, and the final population of the $(Tl^+)^*$ level, which gave us the time dependence of the light output:

$$
\frac{dSTE}{dt} = -\frac{STE}{\tau_{hop}} - \frac{STE}{\tau_{diss}},
$$
\n
$$
\frac{de^{-}}{dt} = \frac{STE}{\tau_{diss}} - \frac{e^{-}}{\tau_{trap}} + \frac{Tl_{e^{-}}^{0}}{\tau_{dtrap}} - \frac{e^{-}Tl_{h^{+}}^{++}}{\tau_{aftgl}^{+}},
$$
\n
$$
\frac{dh^{+}}{dt} = \frac{STE}{\tau_{diss}} - \frac{h^{+}}{\tau_{trap}^{++}} + \frac{Tl_{h^{+}}^{++}}{\tau_{drap}^{++}} - \frac{h^{+}Tl_{e^{-}}^{0}}{\tau_{diff}^{+}},
$$
\n
$$
\frac{dTl_{e^{-}}^{0}}{dt} = \frac{e^{-}}{\tau_{trap}^{0}} - \frac{Tl_{e^{-}}^{0}}{\tau_{drap}^{0}} - \frac{h^{+}Tl_{e^{-}}^{0}}{\tau_{diff}^{+}},
$$
\n
$$
\frac{dTl_{h^{+}}^{++}}{dt} = \frac{h^{+}}{\tau_{trap}^{++}} - \frac{Tl_{h^{+}}^{++}}{\tau_{drap}^{+}} - \frac{e^{-}Tl_{h^{+}}^{++}}{\tau_{aftgl}},
$$
\n
$$
\frac{dTl_{popul}^{+*}}{dt} = \frac{STE}{\tau_{hop}} + \frac{h^{+}Tl_{e^{-}}^{0}}{\tau_{diff}} + \frac{e^{-}Tl_{h^{+}}^{++}}{\tau_{aftgl}} - \frac{Tl_{popul}^{+*}}{\tau_{scin}}.
$$

The equations include nonlinear bimolecular terms describing the diffusion of the holes from (Tl^{++}) to (Tl^0) and thermoactivated transport of the electrons from (Tl^0) to (Tl^{++}) that are responsible for afterglow. We numerically solved this stiff system of ordinary differential equations using a standard MatLab program, ode15s. Our variables are as follows:

- (1) *STE* density of the STEs.
- (2) e^- density of the electrons.
- (3) h ⁺ density of the holes.
- (4) $T l_{e^-}^0$ density of trapped electrons at $T l^0$ levels.
- (5) Tl_{h+}^{++} density of trapped holes at Tl^{++} levels.
- (6) $T l_{popul}^{+*}$ population of $(Tl^+)^*$ excited levels.

The parameters are also shown below:

- (1) τ_{hop} the lifetime at the STE level, combined with the time an exciton needs, via hopping, to reach the Tl excited level.
- (2) τ_{diss} the time an STE needs to decay to electron and hole via multiphonon dissociation.
- (3) τ_{trap}^0 the lifetime of an electron before it is trapped at Tl^0 .
- (4) τ_{trap}^{++} the lifetime of a hole before it is trapped at Tl^{++} .
- (5) τ_{affgl} the time an electron trapped at the Tl^0 level needs to reach and recombine with a hole trapped at Tl^{++} via thermoactivation.
- (6) τ_{diff} the time a hole needs, after detrapping from the TI^{++} level, to reach and recombine with an electron trapped at Tl^0 via diffusion.
- (7) τ_{scint} the lifetime at excited Tl level.
- (8) τ_{dtrap}^{++} the lifetime of a trapped hole at the Tl^{++} level.
- (9) τ_{dtrap}^0 the lifetime of a trapped electron at the Tl^0 level.

The most important parameters we used are well known: the lifetime of the trapped hole is approximately 0.350 μ sec [\[23\]](#page-5-22), and the lifetime of the $(Tl^+)^*$ excited levels is approximately 0.134 µsec [\[6\]](#page-5-5). Less well known are the other parameters such as the multiphonon dissociation time, phonon-assisted hopping time, etc., which we varied. But provided these parameters are kept within reasonable ranges, the overall results are insensitive to their values. The values we used for $T = -20^{\circ}$ C and for $T = +50$ ^oC are shown in Table I.

TABLE I: Parameters Used in Simulations (nsec)

		$T[C] \ \ \tau_{hop} \ \ \tau_{diss} \ \ \tau_{trap}^{0} \ \ \tau_{dtrap}^{0} \ \ \tau_{trap}^{++} \ \ \tau_{dtrap}^{++} \ \ \tau_{diff} \ \ \tau_{scin} \ \ \tau_{aftgl}$			
		$\overline{-20^0}$ 90 70 4 200 1 350 1 134 2.10 ⁵			
		$+50^0$ 4.2 60 50 20 50 350 10^{-2} 134 10^3			

The obtained solutions fit our experimental results very well, as can be seen in Fig 4. This figure clearly

shows the overall nonexponential form of both the experimental results and the model.

FIG. 4: Two of the experimentally measured current pulses normalized by area for NaI(Tl) at $-20^{\circ}C$ (upper curve) and $+50^0C$ (lower curve) are shown in grey dots. The numerical solutions of the nonlinear rate-equation model are shown in black dots. The inset shows the same pulses on a 1 μ sec scale.

IV. CONCLUSIONS

We have presented a model of two competing transport processes that explains the existence of two temporal components in the scintillation of NaI(Tl). While the linear temperature dependence of the total light output is due to the presence of a nonradiative decay channel from the activator level, a much stronger temperature dependence in NaI(Tl) arises because of the temperatureactivated type dependence of the ratio between the fast and slow components. These two nonexponential components correspond to two distinct mechanisms of transport to the activator levels. One of the predictions made by the model is that the differential light output as a function of the energy of the ionizing particle will depend on the temperature. Furthermore, the temperature dependence of the shape of the light pulses, for a given initial energy, will depend on the level of doping because it arises form the competition between unimolecular and bimolecular processes. In a subsequent publication, we will consider these topics, and we will argue that the difference in the transition rates between NaI(Tl) and CsI(Tl) is determined by the differences between the available phonon density of states at the activation energy for these two materials.

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